QLF063A-85A0 /QLF063D-85A0

685 nm 100mW FP LASER TO-CAN

#QD LASER

Preliminary C00260-01 July 2021



1. DESCRIPTION

The QLF063A-85A0/QLF063D-85A0 are 685 nm quantum well laser devices designed for high output power application. The laser diode is mounted into a TO-56 header including a monitor PD and hermetic sealed with a flat glass cap.

FEATURES 2.

- 685 nm FP-LD
- Φ5.6mm TO-CAN package .
- High output power of 100mW and high slope efficiency .
- Including monitor PD .
- Two types of pin assignments: anode common type (QLF063A-85A0)/cathode common type (QLF063D-85A0) .

APPLICATIONS 3.

- Industrial laser markers •
- Measuring instruments •
- Life science applications •

ABSOLUTE MAXIMUM RATING 4.

(CW operation, $T_c = 25^{\circ}$ C, unless otherwise specified)

	(811 8)	peration, 10 25 c, antess other wise specifica		
PARAMETER	SYMBOL	RATING	UNIT	
Optical output power	Po	105	mW	
LD reverse voltage	V _{RLD}	2	V	
PD reverse voltage	V _{RPD}	30	V	
Operation temperature	T _c	-10 to 70	°C	
Storage temperature	T _{stg}	-40 to 85	°C	



QD LASER QLF063A-85A0/QLF063D-85A0

OPTICAL AND ELECTRICAL CHARACTERISTICS 5.

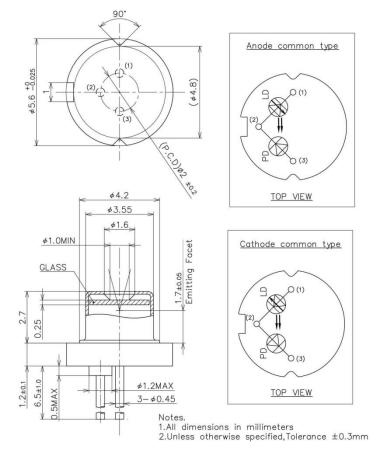
 $(T_c = 25^{\circ}C, unless otherwise specified)$

			(-0			e speemea
PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Threshold current	I _{th}	CW	-	40	-	mA
Operation current	Iop	CW, P _o =100 mW	-	125	-	mA
Operation voltage	V_{op}	CW, P _o =100 mW	-	2.35	-	V
Slope efficiency	η	CW, P _o =5 - 100 mW	-	1.17	-	W/A
Monitor current	Im	CW, P _o =100 mW,	-	TBD	-	μΑ
Peak wavelength	λ_{p}	CW, P _o =100 mW	-	685	-	nm
Beam divergence* Horizontal	θ_{h}	CW, P _o =100 mW	-	9	-	deg.
Beam divergence* vertical	$\theta_{\rm v}$	CW, P _o =100 mW	-	14	-	deg.
Beam angle Horizontal	$\Delta \theta_{ m h}$	CW, P _o =100 mW	-3	-	3	deg.
Beam angle vertical	$\Delta \theta_{ m v}$	CW, P _o =100 mW	-3	-	3	deg.

*Beam divergence is FWHM of far field pattern.



OUTLINE DRAWINGS 6.



NOTICE 7.

• Safety Information

This product is classified as Class 3B laser product, and complies with 21 CFR Part 1040.10.

Please do not take a look at laser lighting in operations since laser devices may cause troubles to human eyes.

Please do not eat, burn, break and make chemical process of the products since they contain GaAs material.

Handling products •

Semiconductor lasers are easily damaged by external stress such as excess temperature and ESD. Please pay attention to handling products, and use within range of maximum ratings. QD Laser takes no responsibility for any failure or unusual operation resulting from improper handling, or unusual physical or electrical stress.

RoHS

This product conforms to RoHS compliance related Directive (EU) 2015/863.

QD Laser, Inc.

Contact : info@qdlaser.com http://www.qdlaser.com

Copyright 2021 All Rights Reserved by QD Laser, Inc.

Keihin Bldg. 1F 1-1 Minamiwatarida-cho, Kawasaki-ku, Kawasaki, Kanagawa Zip 210-0855 Japan

All company or product names mentioned herein are trademarks or registered trademarks of their respective owners. Information provided in this data sheet is accurate at time of publication and is subject to change without advance notice.



3/3

PIECHNOIOGIES AP Technologies Limited The Coach House Watery Lane Bath BA21RL T: 144 (0) 1225 780400 F: +44 (0) 8701 266449 E: info@aptechnologies.co.uk